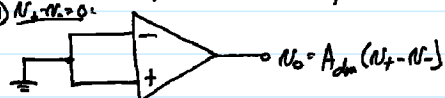


Device Mismatch Effects in Diff. Amplifiers

⇒ up to this point, we assumed that  $Q_1$  &  $Q_2$  are perfectly matched  
⇒ in actual ckt., get device mismatches due to processing variations

The Results

①  $N_1 = N_2 = 0$ : Output not zero when Input is zero →  $N_0 \neq 0$  when  $N_1 = N_2 = 0!$



Ideal Case:  $N_0 = 0$

Reality:  $N_0 \neq 0$ , even if  $(N_1 - N_2) = 0!$

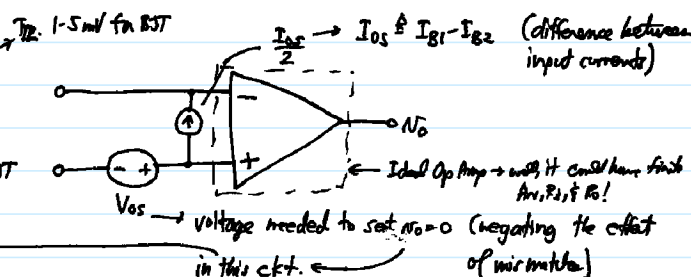
② Input  $I_{B1} \neq I_{B2}$  if  $Q_1$  &  $Q_2$  not matched. (for BJT & JFET only)

To model these effects, introduce:

① Input Offset Voltage,  $V_{os}$

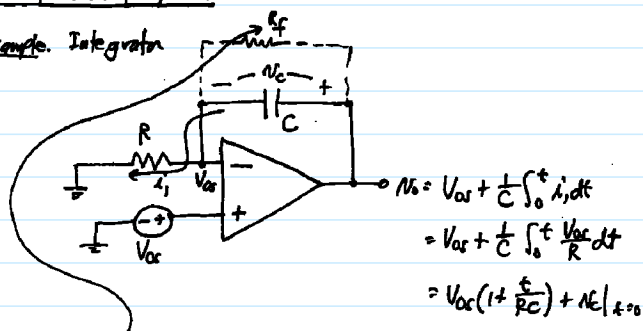
② Input Offset Current,  $I_{os}$

Typ.  $I_{os} = 10 \text{ nA}$  for BJT



Effect of  $V_{os}$  on Op Amp Ckt. -

Example. Integrator



$$N_0 = V_{os} + \frac{1}{C} \int_0^t i_1 dt$$

$$= V_{os} + \frac{1}{C} \int_0^t \frac{V_{os}}{R} dt$$

$$= V_{os} \left(1 + \frac{t}{RC}\right) + N_0|_{t=0}$$



Fix: Place an  $R_f$  in shunt w/ the C

→ then  $N_0 = V_{os} \left(1 + \frac{R_f}{R}\right)$ , and railing doesn't happen

⇒ but, usually  $R_f$  is large to allow the C to dominate

the integrator Xfn Function ∴  $N_0 = V_{os} \left(1 + \frac{R_f}{R}\right)$  can be quite large ⇒ still want  $V_{os} = \text{small}$

$V_{os}$  is even more important in setting the resolution of AD converters and other precision ckt.

EE 140/240A

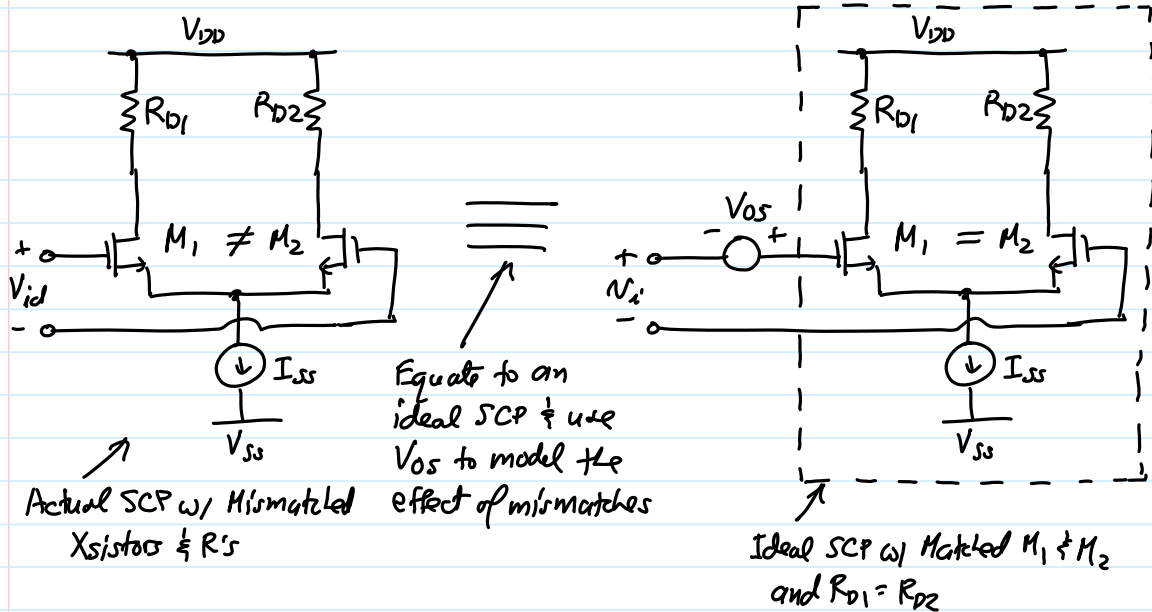
$V_{OS}$  of a Mismatched SCP

CTN

2

$V_{OS}$  of a Mismatched SCP

Objective: Derive an expression for  $V_{OS}$ .



Input offset voltage  $V_{OS}$  arises due to variations in:

- ① Xsistors,  $M_1 \neq M_2 \rightarrow \frac{W}{L}$  and  $V_t$  vary
- ②  $R_{D1} \neq R_{D2} \rightarrow$  causes gain variation

Definition:  $V_{OS} = V_{id}$  to get  $V_{od} = 0$  in this ckt.

KVL:  $V_{OS} - V_{GS1} + V_{GS2} = 0$

$$\therefore V_{OS} = V_{GS1} - V_{GS2} = V_{t1} + \sqrt{\frac{2I_{D1}}{\mu_n C_{ox}(W/L)_1}} - V_{t2} - \sqrt{\frac{2I_{D2}}{\mu_n C_{ox}(W/L)_2}}$$

$$V_{OS} = V_{t1} - V_{t2} + \sqrt{\frac{2I_{D1}}{\mu_n C_{ox}(W/L)_1}} - \sqrt{\frac{2I_{D2}}{\mu_n C_{ox}(W/L)_2}} \quad (1)$$

Define difference and average quantities:

$\Delta I_D = I_{D1} - I_{D2}$	$\Delta\left(\frac{W}{L}\right) = \left(\frac{W}{L}\right)_1 - \left(\frac{W}{L}\right)_2$	$\Delta V_t = V_{t1} - V_{t2}$	$\Delta R_D = R_{D1} - R_{D2}$
$I_D = \frac{I_{D1} + I_{D2}}{2}$	$\left(\frac{W}{L}\right) = \frac{1}{2} \left[ \left(\frac{W}{L}\right)_1 + \left(\frac{W}{L}\right)_2 \right]$	$V_t = \frac{V_{t1} + V_{t2}}{2}$	$R_D = \frac{R_{D1} + R_{D2}}{2}$

EE 140/240A

$V_{OS}$  of a Mismatched SCP

CTN

3

Rearranging:

$$I_{D1} = I_D + \frac{\Delta I_D}{2} \quad \left(\frac{W}{L}\right)_1 = \left(\frac{W}{L}\right) + \frac{\Delta(W/L)}{2} \quad V_{t1} = V_t + \frac{\Delta V_t}{2}$$

$$I_{D2} = I_D - \frac{\Delta I_D}{2} \quad \left(\frac{W}{L}\right)_2 = \left(\frac{W}{L}\right) - \frac{\Delta(W/L)}{2} \quad V_{t2} = V_t - \frac{\Delta V_t}{2}$$

Substituting into (1):

$$V_{OS} = \Delta V_t + \sqrt{\frac{2(I_D + \frac{\Delta I_D}{2})}{\mu_n C_{ox} \left[ \left(\frac{W}{L}\right)_1 + \frac{1}{2} \Delta \left(\frac{W}{L}\right) \right]}} - \sqrt{\frac{2(I_D - \frac{\Delta I_D}{2})}{\mu_n C_{ox} \left[ \left(\frac{W}{L}\right)_2 - \frac{1}{2} \Delta \left(\frac{W}{L}\right) \right]}}$$

$$V_{GS} - V_t = \sqrt{\frac{2I_D}{\mu_n C_{ox} (W/L)}} \left\{ \sqrt{\frac{1 + \frac{\Delta I_D}{2I_D}}{1 + \frac{1}{2} \frac{\Delta(W/L)}{(W/L)}}} - \sqrt{\frac{1 - \frac{\Delta I_D}{2I_D}}{1 - \frac{1}{2} \frac{\Delta(W/L)}{(W/L)}}} \right\}$$

Binomial Theorem:

$$(1+nx)^m \xrightarrow{n=\text{small}} 1+mnx$$

$$V_{OS} = \Delta V_t + (V_{GS} - V_t) \left\{ \left(1 + \frac{1}{4} \frac{\Delta I_D}{I_D}\right) \left(1 - \frac{1}{4} \frac{\Delta(W/L)}{(W/L)}\right) - \left(1 - \frac{1}{4} \frac{\Delta I_D}{I_D}\right) \left(1 + \frac{1}{4} \frac{\Delta(W/L)}{(W/L)}\right) \right\}$$

$$= \Delta V_t + (V_{GS} - V_t) \left( \frac{1}{2} \frac{\Delta I_D}{I_D} - \frac{1}{2} \frac{\Delta(W/L)}{(W/L)} \right)$$

$$\therefore V_{OS} = \Delta V_t + \frac{1}{2} (V_{GS} - V_t) \left\{ \frac{\Delta I_D}{I_D} - \frac{\Delta(W/L)}{(W/L)} \right\}$$

When  $V_{id} = V_{OS} \rightarrow V_{od} = 0 \therefore I_{D1}R_{D1} = I_{D2}R_{D2} \rightarrow$  mismatch in  $I_D$  must be opposite

$$V_{OS} = \Delta V_t + \frac{1}{2} (V_{GS} - V_t) \left\{ -\frac{\Delta R}{R} - \frac{\Delta(W/L)}{(W/L)} \right\}$$

Threshold Mismatch

bias independent

Geometric (i.e., Layout) Variation

scale w/ overdrive

that of  $R_D$

$$\frac{\Delta I_D}{I_D} = -\frac{\Delta R_D}{R_D}$$